

Notice of References Cited	Application/Control No. 10/617,811		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Cynthia Lee		Art Unit 1745	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0177027	11-2002	Yeager et al.	429/34
*	B	US-6,645,671	11-2003	Tsutsumi et al.	429/212
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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